

## **Quarterly Reliability Monitoring Results**

## Quarters: Q1/2022 to Q4/2023

Based on structural similarity

| Supplier Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test |                             | User Part Number PESD2CANFD36UQB-Q                  |             |           |            |           |  |  |
|--|-----------------------------|---|-------------|-----------|------------|-----------|--|--|
|  |                             |   |             |           |            |           |  |  |
|  |                             | Nexperia DHAM Protection Bipolar                    |             |           |            |           |  |  |
|  |                             | MCD package   |             |           |            |           |  |  |
|  |                             | Test Conditions                                     | Duration    | # Lots    | # Quantity | # Rejects |  |  |
|  |                             |   | TEST        |           |            |           |  |  |
|  | Pre- and Post-Stress        |   |             |           |            |           |  |  |
| # E1   | Electrical Test             | Tamb = 25 °C  | N/A         | see below | all parts  | see below |  |  |
|  |                             | JESD22-A113   |             |           |            |           |  |  |
|  |                             | Bake Tamb = 125 °C                                  | 24 hours    |           |            |           |  |  |
|  | PC                          | Soak Tamb = 85 °C, RH = 85%                         | 168 hours   |           |            |           |  |  |
| # A1   | Preconditioning             | Reflow soldering                                    | 3 cycles    | 228       | 10140      | 0         |  |  |
| l  |                             | MIL-STD-750-1                                       |             |           |            |           |  |  |
|  | HTRB                        | M1038 Method A                                      |             |           |            |           |  |  |
|  | <b>.</b>                    | Tj = Tjmax, Vr = 100% of max. datasheet             |             |           |            |           |  |  |
| # B1   | Bias                        | reverse voltage                                     | 1000 hours  | 45        | 2000       | 0         |  |  |
|  |                             | JECD22 4404   |             |           |            |           |  |  |
|  | TC Temperature Cycling      | JESD22-A104<br>-65 °C to Timax, not to exceed 150°C | 1000        | 0.5       | 2020       |           |  |  |
| # A4   | remperature Cycling         | -03 C to Tjillax, flot to exceed 130 C              | 1000 cycles | 86        | 3830       | 0         |  |  |
|  | UHAST                       | JESD22-A118   |             |           |            |           |  |  |
| # A3 or  | Unbiased HAST               | Tamb = 130 °C, RH = 85 %                            | — 96 hours  | 59        | 2615       | 0         |  |  |
|  |                             | JESD22-A102   |             |           |            |           |  |  |
|  | AC                          | Tamb = 121 °C, RH = 100 %                           |             |           |            |           |  |  |
| # A3 alt   | Autoclave                   | Pressure = 205 kPa (29.7 psia)                      |             |           |            |           |  |  |
|  |                             |   |             |           |            |           |  |  |
|  | <b>НЗТ</b> В                | JESD22-A101   |             |           |            |           |  |  |
|  | High Humidity High          | Tamb = 85 °C, RH = 85%, VR = 80 % of                |             |           |            |           |  |  |
| # A2 alt   | Temperature Reverse Bias    | rated reverse voltage <sup>[1]</sup>                | 1000 hours  | 83        | 3695       | 0         |  |  |
|  |                             | MIL-STD-750 Method 1037                             |             |           |            |           |  |  |
|  | IOL                         | ton = toff, devices powered to insure $\Delta Tj$ = |             |           |            |           |  |  |
| # A5   | Intermittent Operating Life | 100 °C for 15000 cycles                             | 1000 hours  | n.a.      | n.a.       | n.a.      |  |  |
|  |                             |   |             |           |            |           |  |  |
|  | RSH                         | JESD22-A111   |             |           |            |           |  |  |
| # C8   | Resistance to Solder Heat   | 260 °C ± 5 °C                                       | 10 s        | n.a.      | n.a.       | n.a.      |  |  |
|  | SD                          |   |             |           |            |           |  |  |
| # C10  | Solderability               | J-STD-002   |             | 32        | 960        | 0         |  |  |

<sup>[1]</sup> The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Wafer Fab | Technology         | Quantity | Rejects | Failure Rate (FIT) | MTTF (hrs) |
|-----------|--------------------|----------|---------|--------------------|------------|
| Nexperia  |                    |          |         |                    |            |
| DHAM      | Protection Bipolar | 2000     | 0       | 2,12               | 4,71E+08   |

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